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Application/Control No.	Applicant(s)/Patent under Reexamination	٠
09/848,952	LURIE ET AL.	
Examiner	Art Unit	
J. Derek Rutten	2192	

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INT	INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
717/104-113 707/10,102 text search only See search history printout	4/16/2007	JDR		
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	4/16/2007	JDR		
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	4/17/2007	JDR		
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